QMA (Snap-On Mating Style Coaxial Connector)

1. SCOPE

1.1. Content

This specification covers performance, tests and quality requirements for the Tyco Electronics QMA snap-on mating style coaxial connector. This connector mates when fingers on the outer contact of the plug snap over a step on the jack housing. Pulling back on the outer housing of the plug opens the fingers which releases the connector.

1.2. Qualification

When tests are performed on the subject product line, procedures specified in Figure 1 shall be used. All inspections shall be performed using the applicable inspection plan and product drawing.

1.3. Qualification Test Results

Successful qualification testing on the subject product line was completed on 26Sep03. The Qualification Test Report number for this testing is 501-572. This documentation is on file at and available from Engineering Practices and Standards (EPS).

2. APPLICABLE DOCUMENTS

The following documents form a part of this specification to the extent specified herein. Unless otherwise specified, the latest edition of the document applies. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

2.1. Tyco Electronics Documents

- 109-197: AMP Test Specifications vs EIA and IEC Test Methods
- 501-572: Qualification Test Report

2.2. Commercial Standard

EIA-364: Electrical Connector/Socket Test Procedures Including Environmental Classifications

3. REQUIREMENTS

3.1. Design and Construction

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

3.2. Materials

Materials used in the construction of this product shall be as specified on the applicable product drawing.

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3.3. Ratings

- Voltage: 335 volts AC
- Temperature: -40 to 80˚C
- Characteristic Impedance: 50 ohms
- Frequency Range: DC to 6000 MHz

3.4. Performance and Test Description

Product is designed to meet the electrical, mechanical and environmental performance requirements specified in Figure 1. Unless otherwise specified, all tests shall be performed at ambient environmental conditions per EIA-364.

3.5. Test Requirements and Procedures Summary

Test Description	Requirement	Procedure
Initial examination of product.	Meets requirements of product drawing.	EIA-364-18. Visual and dimensional (C of C) inspection per product drawing.
Final examination of product.	Meets visual requirements.	EIA-364-18. Visual inspection.
ELECTRICAL		
Low level contact resistance.	5 milliohms maximum for center contact. 2.5 milliohms maximum for outer contact.	EIA-364-23. Subject specimens to 100 milliamperes maximum and 20 millivolts maximum open circuit voltage.
Voltage standing wave ratio.	1.15 maximum for straight product. 1.22 maximum for right angle product. Not applicable to PWB product.	EIA-364-108. Measure VSWR between 0 and 6000 MHz.
Insulation resistance.	5000 megohms minimum.	EIA-364-21. Test between adjacent contacts.
Withstanding voltage.	1 minute hold with no breakdown or flashover.	EIA-364-20, Condition I. 750 volts AC at sea level for RG 316 and RD 316 cable connectors. 1000 volts AC at sea level for adapters, receptacles, RG 58, RG 400 and .141 semi-rigid connectors. Test between adjacent contacts.
RF insertion loss.	.25 dB maximum. Not applicable to PWB product.	EIA-364-101, Method A. Measure RF insertion loss at 6000 MHz.
MECHANICAL		
Solderability, dip test.	Solderable area shall have a minimum of 95% solder coverage.	EIA-364-52, Category 3. Subject contacts to solderability.

Figure 1 (cont)

Test Description	Requirement	Procedure
Vibration, random.	No discontinuities of 1 microsecond or longer duration. See Note.	EIA-364-28, Test Condition VII, Condition D. Subject mated specimens to 3.10 G's rms between 20-500 Hz. 15 minutes in each of 3 mutually perpendicular planes.
Mechanical shock.	No discontinuities of 1 microsecond or longer duration. See Note.	EIA-364-27, Method H. Subject mated specimens to 30 G's half-sine shock pulses of 11 milliseconds duration. 3 shocks in each direction applied along 3 mutually perpendicular planes, 18 total shocks.
Durability.	See Note.	EIA-364-9. Mate and unmate specimens for 100 cycles at a maximum rate of 500 cycles per hour.
Interface retention force.	60 N minimum without pulling the release ring on the plug.	EIA-364-98. Apply force to failure at a maximum rate of 12.7 mm per minute.
ENVIRONMENTAL		
Thermal shock.	See Note.	EIA-364-32. Subject mated specimens to 5 cycles between -40 and 80˚C.
Humidity-temperature cycling.	See Note.	EIA-364-31, Method III. Subject mated specimens to 10 cycles (10 days) between 25 and 65˚C at 80 to 100% RH.
Temperature life.	See Note.	EIA-364-17, Method A, Test Time Condition C. Subject mated specimens to 80˚C for 500 hours.
Mixed flowing gas.	See Note.	EIA-364-65, Class IIA (4 gas). Subject mated specimens to environmental Class IIA for 20 days.

NOTE *Shall meet visual requirements, show no physical damage, and meet requirements of additional tests as specified in the Product Qualification and Requalification Test Sequence shown in Figure 2.*

Figure 1 (end)

3.6. Product Qualification and Requalification Test Sequence

Test or Examination	Test Group (a)						
	1	2	3	4	5	6	7
	Test Sequence (b)						
Initial examination of product	1	1	1	1	1	1	1
Low level contact resistance	2,6	2,4	2,4				
Voltage standing wave ratio					2		
Insulation resistance				2,6			
Withstanding voltage				3,7			
RF insertion loss					3		
Solderability						2	
Vibration	4						
Mechanical shock	5						
Durability	3						
Interface retention force							2
Thermal shock				4			
Humidity-temperature cycling				5			
Temperature life		3(c)					
Mixed flowing gas			3(c)				
Final examination of product	7	5	5	8	4	3	3

NOTE
(a) See paragraph 4.1.A.
(b) Numbers indicate sequence in which tests are performed.
(c) Precondition specimens with 10 durability cycles.

Figure 2

4. QUALITY ASSURANCE PROVISIONS

4.1. Qualification Testing

A. Specimen Selection

Specimens shall be prepared in accordance with applicable Instruction Sheets and shall be selected at random from current production. All test groups shall each consist of a minimum of 5 specimens.

B. Test Sequence

Qualification inspection shall be verified by testing specimens as specified in Figure 2.

4.2. Requalification Testing

If changes significantly affecting form, fit or function are made to the product or manufacturing process, product assurance shall coordinate requalification testing, consisting of all or part of the original testing sequence as determined by development/product, quality and reliability engineering.

4.3. Acceptance

Acceptance is based on verification that the product meets the requirements of Figure 1. Failures attributed to equipment, test setup or operator deficiencies shall not disqualify the product. If product failure occurs, corrective action shall be taken and specimens resubmitted for qualification. Testing to confirm corrective action is required before resubmittal.

4.4. Quality Conformance Inspection

The applicable quality inspection plan shall specify the sampling acceptable quality level to be used. Dimensional and functional requirements shall be in accordance with the applicable product drawing and this specification.